

# FDMC86320

## N-Channel Power Trench® MOSFET 80 V, 22 A, 11.7 mΩ

### Features

- Max  $r_{DS(on)}$  = 11.7 mΩ at  $V_{GS} = 10\text{ V}$ ,  $I_D = 10.7\text{ A}$
- Max  $r_{DS(on)}$  = 16 mΩ at  $V_{GS} = 8\text{ V}$ ,  $I_D = 8.5\text{ A}$
- MSL1 robust package design
- 100% UIL Tested
- RoHS Compliant

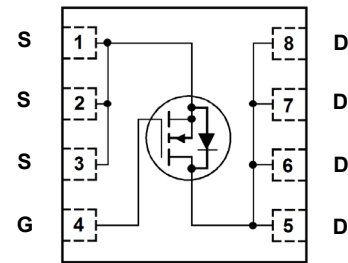
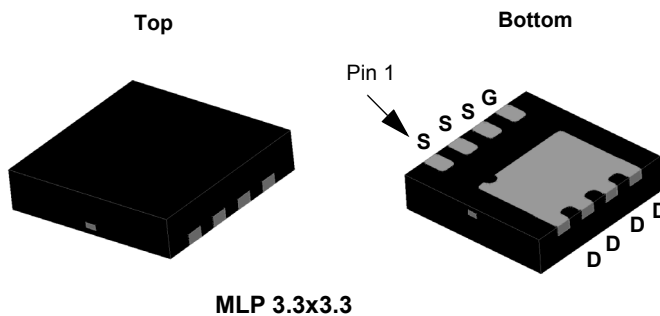


### General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $r_{DS(on)}$ , fast switching speed and body diode reverse recovery performance.

### Applications

- Primary DC-DC Switch
- Motor Bridge Switch
- Synchronous Rectifier



### MOSFET Maximum Ratings $T_A = 25\text{ °C}$ unless otherwise noted

| Symbol         | Parameter  | Ratings     | Units |
|----------------|--|-------------|-------|
| $V_{DS}$       | Drain to Source Voltage  | 80          | V     |
| $V_{GS}$       | Gate to Source Voltage   | ±20         | V     |
| $I_D$          | Drain Current -Continuous (Package limited) $T_C = 25\text{ °C}$ | 22          | A     |
|                | -Continuous (Silicon limited) $T_C = 25\text{ °C}$               | 45          |       |
|                | -Continuous $T_A = 25\text{ °C}$ (Note 1a)                       | 10.7        |       |
|                | -Pulsed  | 50          |       |
| $E_{AS}$       | Single Pulse Avalanche Energy (Note 3)                           | 60          | mJ    |
| $P_D$          | Power Dissipation $T_C = 25\text{ °C}$                           | 40          | W     |
|                | Power Dissipation $T_A = 25\text{ °C}$ (Note 1a)                 | 2.3         |       |
| $T_J, T_{STG}$ | Operating and Storage Junction Temperature Range                 | -55 to +150 | °C    |

### Thermal Characteristics

|                 |   |     |      |
|-----------------|---|-----|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case              | 3.1 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 53  |      |

### Package Marking and Ordering Information

| Device Marking | Device    | Package  | Reel Size | Tape Width | Quantity   |
|----------------|-----------|----------|-----------|------------|------------|
| FDMC86320      | FDMC86320 | Power 33 | 13"       | 12 mm      | 3000 units |

## Electrical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

### Off Characteristics

|                                      |   |   |    |    |           |                      |
|--------------------------------------|---|---|----|----|-----------|----------------------|
| $BV_{DSS}$                           | Drain to Source Breakdown Voltage         | $I_D = 250\text{ }\mu\text{A}$ , $V_{GS} = 0\text{ V}$                    | 80 |    |           | V                    |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$ |    | 56 |           | mV/ $^\circ\text{C}$ |
| $I_{DSS}$                            | Zero Gate Voltage Drain Current           | $V_{DS} = 64\text{ V}$ , $V_{GS} = 0\text{ V}$                            |    |    | 1         | $\mu\text{A}$        |
| $I_{GSS}$                            | Gate to Source Leakage Current            | $V_{GS} = \pm 20\text{ V}$ , $V_{DS} = 0\text{ V}$                        |    |    | $\pm 100$ | nA                   |

### On Characteristics

|  |  |  |     |      |      |                      |
|--|--|--|-----|------|------|----------------------|
| $V_{GS(th)}$                           | Gate to Source Threshold Voltage                         | $V_{GS} = V_{DS}$ , $I_D = 250\text{ }\mu\text{A}$                                 | 2.4 | 3.5  | 4.5  | V                    |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$          |     | -11  |      | mV/ $^\circ\text{C}$ |
| $r_{DS(on)}$                           | Static Drain to Source On Resistance                     | $V_{GS} = 10\text{ V}$ , $I_D = 10.7\text{ A}$                                     |     | 9.7  | 11.7 | m $\Omega$           |
|  |  | $V_{GS} = 8\text{ V}$ , $I_D = 8.5\text{ A}$                                       |     | 11.4 | 16   |                      |
|  |  | $V_{GS} = 10\text{ V}$ , $I_D = 10.7\text{ A}$ , $T_J = 125\text{ }^\circ\text{C}$ |     | 15   | 18   |                      |
| $g_{FS}$                               | Forward Transconductance                                 | $V_{DS} = 10\text{ V}$ , $I_D = 10.7\text{ A}$                                     |     | 20   |      | S                    |

### Dynamic Characteristics

|           |                              |  |  |      |      |          |
|-----------|------------------------------|--|--|------|------|----------|
| $C_{iss}$ | Input Capacitance            | $V_{DS} = 40\text{ V}$ , $V_{GS} = 0\text{ V}$ ,<br>$f = 1\text{ MHz}$ |  | 1985 | 2640 | pF       |
| $C_{oss}$ | Output Capacitance           |  |  | 353  | 469  | pF       |
| $C_{rss}$ | Reverse Transfer Capacitance |  |  | 12   | 30   | pF       |
| $R_g$     | Gate Resistance              |  |  | 0.5  |      | $\Omega$ |

### Switching Characteristics

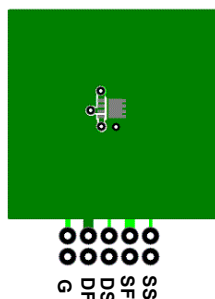
|              |                               |  |                                      |   |    |    |
|--------------|-------------------------------|--|--------------------------------------|---|----|----|
| $t_{d(on)}$  | Turn-On Delay Time            | $V_{DD} = 40\text{ V}$ , $I_D = 10.7\text{ A}$ ,<br>$V_{GS} = 10\text{ V}$ , $R_{GEN} = 6\text{ }\Omega$ |                                      | 15  | 28 | ns |
| $t_r$        | Rise Time                     |  |                                      | 8   | 16 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time           |  |                                      | 20  | 35 | ns |
| $t_f$        | Fall Time                     |  |                                      | 5   | 10 | ns |
| $Q_{g(TOT)}$ | Total Gate Charge             |  | $V_{GS} = 0\text{ V to }10\text{ V}$ | $V_{DD} = 40\text{ V}$ ,<br>$I_D = 10.7\text{ A}$ | 29 | 41 |
| $Q_{g(TOT)}$ | Total Gate Charge             | $V_{GS} = 0\text{ V to }8\text{ V}$  | 24                                   |   | 34 | nC |
| $Q_{gs}$     | Total Gate Charge             |  | 10                                   |   |    | nC |
| $Q_{gd}$     | Gate to Drain "Miller" Charge |  | 6.9                                  |   |    | nC |

### Drain-Source Diode Characteristics

|          |                                       |  |  |      |     |    |
|----------|---------------------------------------|--|--|------|-----|----|
| $V_{SD}$ | Source to Drain Diode Forward Voltage | $V_{GS} = 0\text{ V}$ , $I_S = 10.7\text{ A}$ (Note 2)     |  | 0.84 | 1.3 | V  |
|          |                                       | $V_{GS} = 0\text{ V}$ , $I_S = 2\text{ A}$ (Note 2)        |  | 0.75 | 1.2 |    |
| $t_{rr}$ | Reverse Recovery Time                 | $I_F = 10.7\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ |  | 38   | 61  | ns |
| $Q_{rr}$ | Reverse Recovery Charge               |  |  | 27   | 43  | nC |

#### NOTES:

- $R_{\theta JA}$  is determined with the device mounted on a  $1\text{ in}^2$  pad of 2 oz copper pad on a  $1.5 \times 1.5\text{ in.}$  board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a.  $53\text{ }^\circ\text{C/W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz copper



b.  $125\text{ }^\circ\text{C/W}$  when mounted on a minimum pad of 2 oz copper

- Pulse Test: Pulse Width <  $300\text{ }\mu\text{s}$ , Duty cycle < 2.0%.

- Starting  $T_J = 25\text{ }^\circ\text{C}$ ; N-ch:  $L = 0.3\text{ mH}$ ,  $I_{AS} = 20\text{ A}$ ,  $V_{DD} = 72\text{ V}$ ,  $V_{GS} = 10\text{ V}$ .

**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

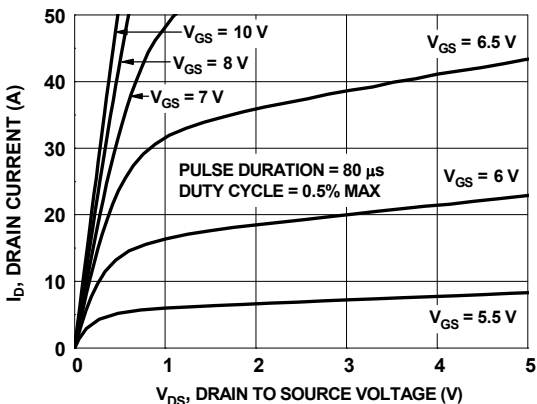


Figure 1. On Region Characteristics

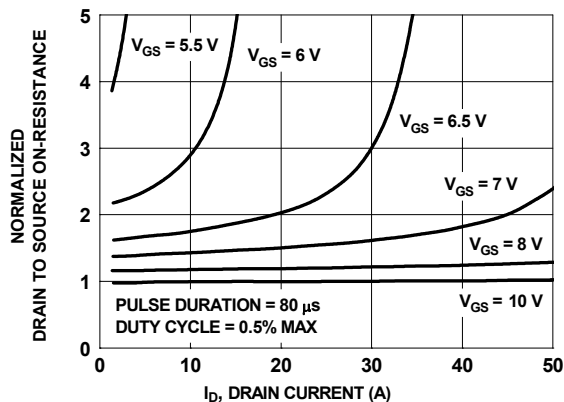


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

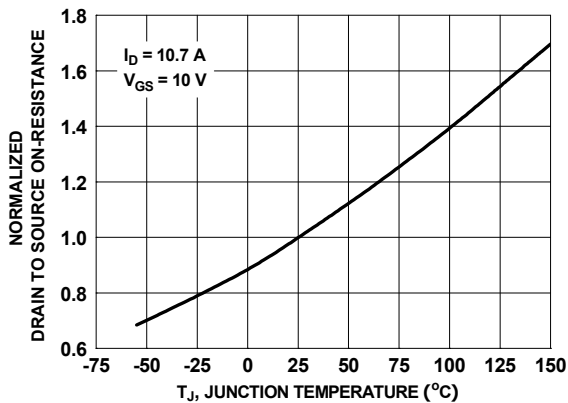


Figure 3. Normalized On Resistance vs Junction Temperature

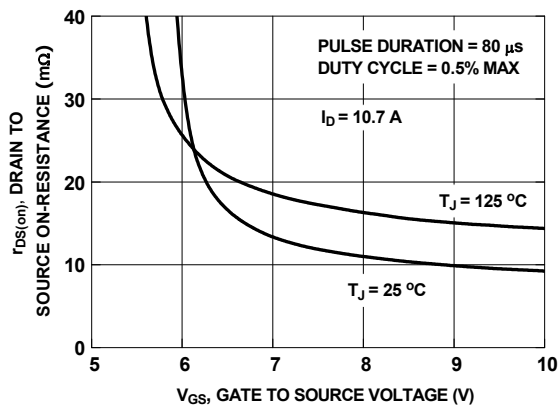


Figure 4. On-Resistance vs Gate to Source Voltage

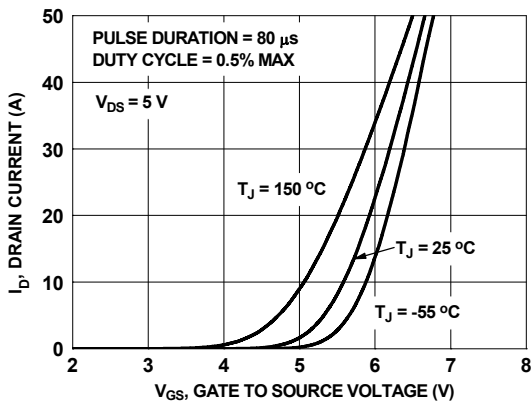


Figure 5. Transfer Characteristics

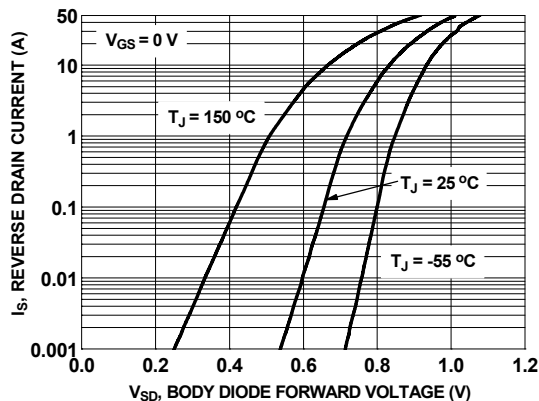
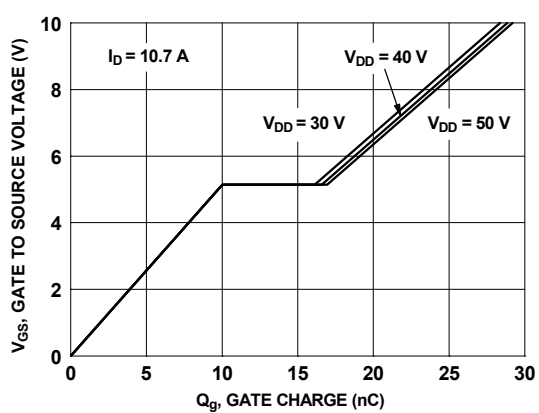
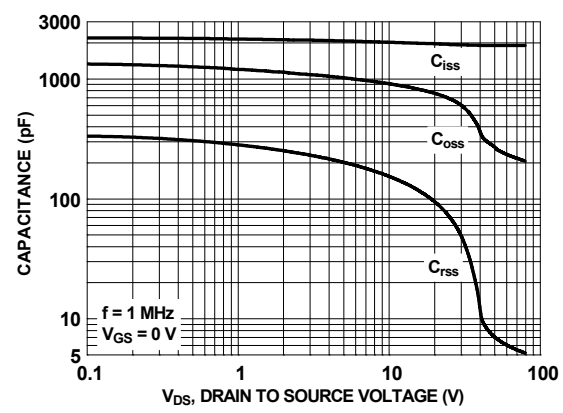


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

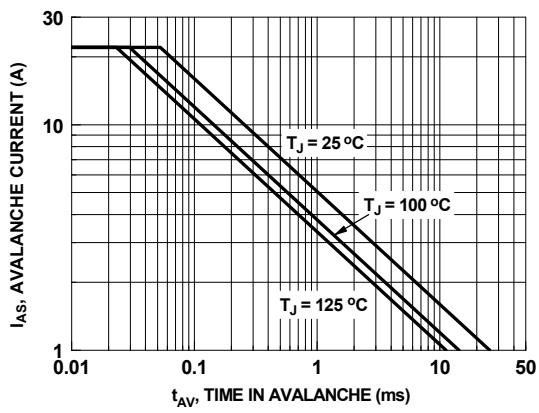
**Typical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted



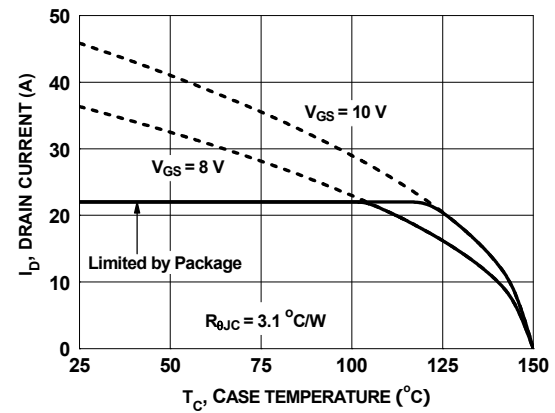
**Figure 7. Gate Charge Characteristics**



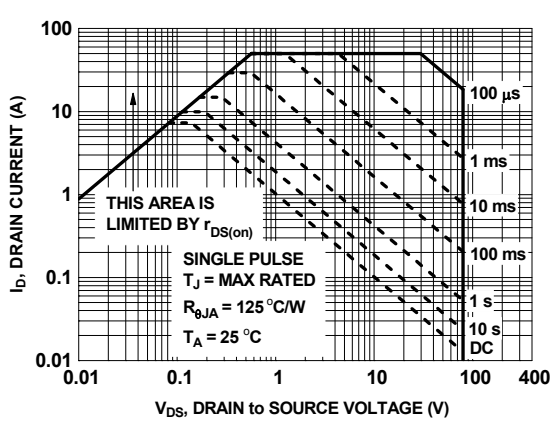
**Figure 8. Capacitance vs Drain to Source Voltage**



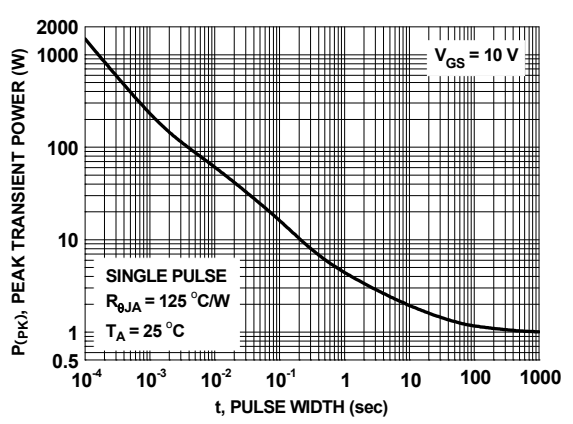
**Figure 9. Unclamped Inductive Switching Capability**



**Figure 10. Maximum Continuous Drain Current vs Case Temperature**

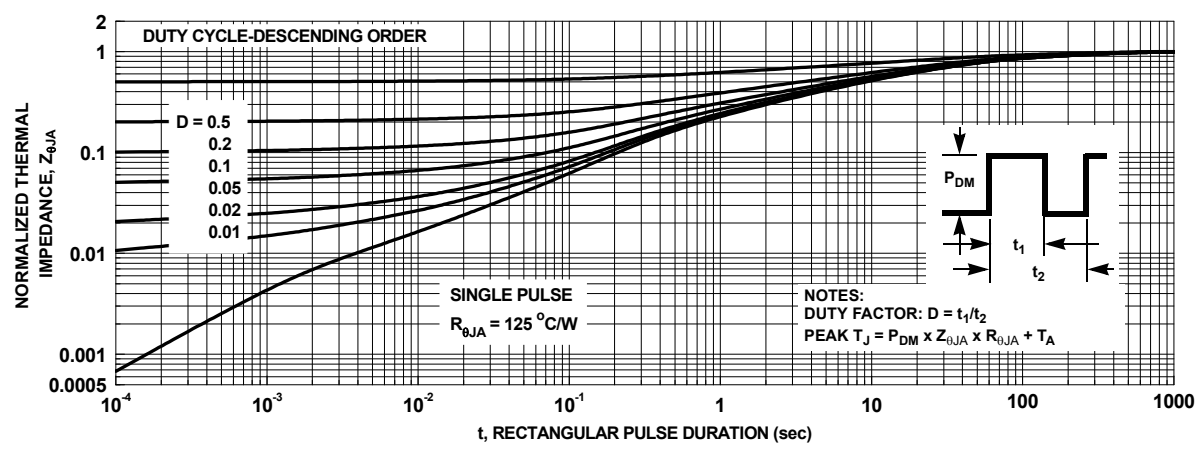


**Figure 11. Forward Bias Safe Operating Area**



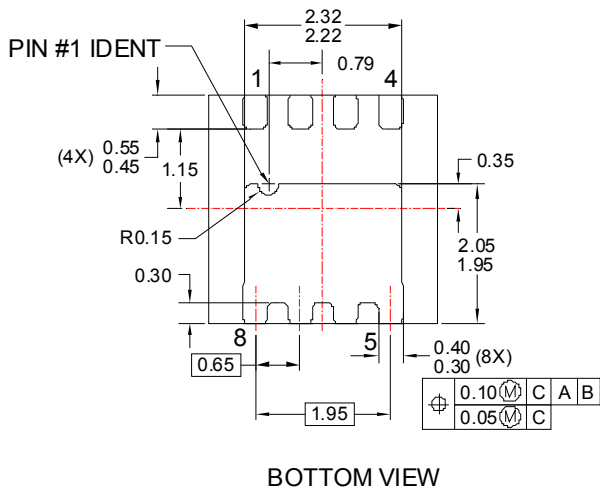
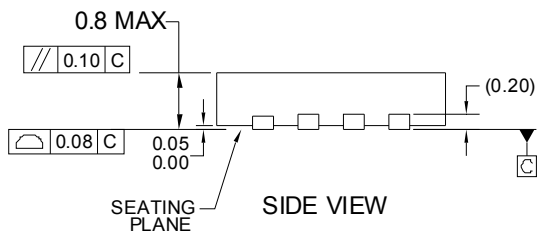
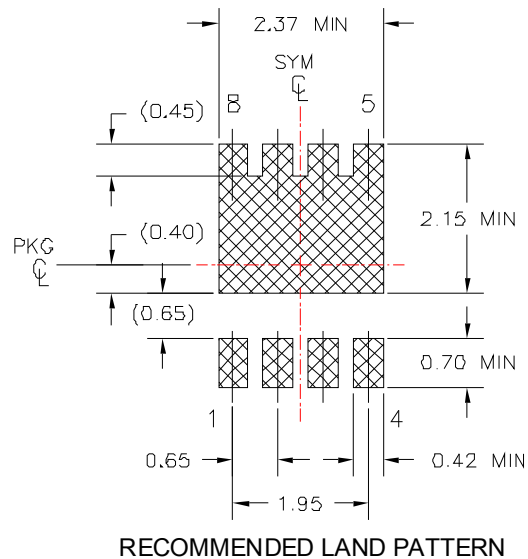
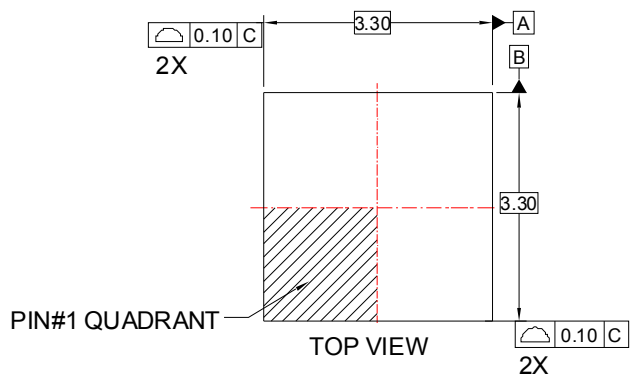
**Figure 12. Single Pulse Maximum Power Dissipation**

**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



**Figure 13. Junction-to-Ambient Transient Thermal Response Curve**

## Dimensional Outline and Pad Layout








### NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994
- D. LAND PATTERN RECOMMENDATION IS BASED ON FSC DESIGN ONLY
- E. DRAWING FILE NAME : MLP08Srev1



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